

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	Confirmation No.: 6160
Keith W. Reiss)	
)	Group Art Unit: 1743
)	
Application Number: 10/607,532)	Examiner: Soderquist, Arlen
)	
Filed: June 27, 2003)	
)	
For: PRECISION ADAPTABLE CHEMICAL SPECTROMETER)	

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. §§ 1.97 and 1.98, and in compliance with the duty of disclosure set forth in 37 C.F.R. § 1.56, applicants are submitting herewith the attached Form PTO/SB08a/b for consideration and to be made of record herein by the U.S. Patent and Trademark Office in the above-captioned application. In accordance with 37 C.F.R. § 1.98(a)(2)(ii) copies of the U.S. patents and U.S. patent application publications are not enclosed.

This Information Disclosure Statement is submitted after the first office action on the merits. Therefore, the fee of \$180 is respectfully submitted. However, in the event any additional fee is deemed necessary, the Commissioner is authorized to charge the undersigned's Deposit Account No. 14-1437.

Respectfully submitted,

NOVAK DRUCE & QUIGG LLP

Dated: July 25, 2007

NOVAK DRUCE & QUIGG LLP
1300 Eye Street, N.W., Suite 1000 West Tower
Washington, DC 20005
202-659-0100 (telephone)
202-659-0105 (facsimile)
Jim.remenick@novakdruce.com

By:



James Remenick
Registration No. 36,902

Substitute for form 1449A/B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Application Number	10/607/532
				Filing Date	June 27, 2003
				First Named Inventor	Keith W. Reiss
				Art Unit	1743
				Examiner Name	Soderquist, Arlen
Sheet	1	of	1	Attorney Docket Number	8107.002.US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	† ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinda Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		† ²
	CA	Albert, S. et al, FASSST: A New Gas-Phase Analytical Tool, Analytical Chemistry News & Features, November 1, 1998, 719.		

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	
-----------------------	--	--------------------	--